Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/046,527	MASSIE ET AL.	SSIE ET AL.
Examiner	Art Unit	Unit
Brian Roberts	2662	2

	SEARCHED				
Class	Subclass	Date	Examiner		
714	750	10/19/2005	BSR		
714	51	10/19/2005	BSR		
714	48	10/19/2005	BSR		
714	748	10/19/2005	BSR		
714	703	10/20/2005	BSR		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
PALM inventor search	10/19/2005	BSR
Consulted with Examiner Greg Sefcheck to focus: 370/229,230,235,277,281,328,329, 389,437,478,480,236 714/51,48,703,748,750	10/19/2005	BSR
IEEE Xplore search utilizing keywords "ARQ" and "HARQ"	10/20/2005	BSR
EAST Text search: See search history printout	10/20/2005	BSR